SDLS108 - APRIL 1985 - REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages in Addition to Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

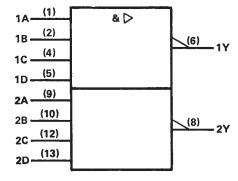
These devices contain two independent 4-input NAND buffer gates.

The SN5440, SN54LS40, and SN54S40 are characterized for operation over the full military temperature range of $-55\,^{\circ}\text{C}$ to $125\,^{\circ}\text{C}$. The SN7440, SN74LS40, and SN74S40 are characterized for operation from $0\,^{\circ}\text{C}$ to $70\,^{\circ}\text{C}$.

FUNCTION TABLE (each gate)

	INP	UTS		OUTPUT
Α	В	С	D	Y
Н	Н	Н	н	L
L	X	X	х	н
Х	L	X	×	н
Х	Х	L	х	Н
x	X	X	L	Н

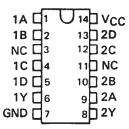
logic symbol†



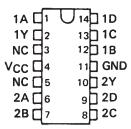
[†]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

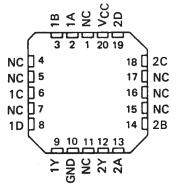
SN5440 . . . J PACKAGE
SN54LS40, SN54S40 . . . J OR W PACKAGE
SN7440 . . . N PACKAGE
SN74LS40, SN74S40 . . . D OR N PACKAGE
(TOP VIEW)



SN5440 . . . W PACKAGE (TOP VIEW)

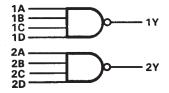


SN54LS40, SN54S40 . . . FK PACKAGE (TOP VIEW)



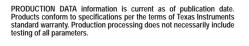
NC - No internal connection

logic diagram



positive logic

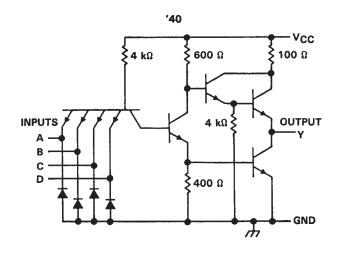
 $Y = \overline{A \cdot B \cdot C \cdot D}$ or $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$

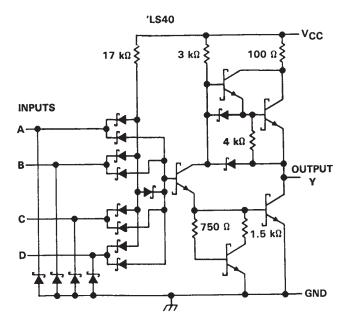


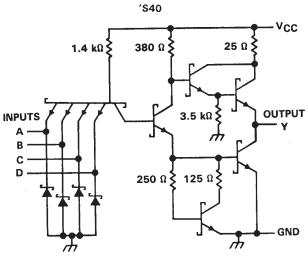


SDLS108 - APRIL 1985 - REVISED MARCH 1988

schematics (each gate)







Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)	1
nput voltage: '40, 'S40	,
'LS40 7 V	1
Operating free-air temperature range: SN54'	,
SN74'	,
Storage temperature range65°C to 150°C	

NOTE 1: Voltage values are with respect to network ground terminal.



SDLS108 – APRIL 1985 – REVISED MARCH 1988

recommended operating conditions

			SN5440)	SN7440		UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	ONLL
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
ЮН	High-level output current			- 1.2			- 1.2	mA
loL	Low-level output current			48			48	mA
TA	Operating free-air temperature	- 55		125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †			SN5440			SN7440			
PARAMETER		LEST CONDIT	IONS I	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIK	V _{CC} = MIN,	I _I = - 12 mA				- 1.5			- 1.5	V
Voн	V _{CC} = MIN,	V ₁ L = 0.8 V,	I _{OH} = - 1.2 mA	2.4	3.3		2.4	3.3		٧
VOL	V _{CC} = MIN,	V _{IH} = 2 V,	IOL = 48 mA		0.2	0.4		0.2	0.4	V
Τį	V _{CC} = MAX,	V _I = 5.5 V				1			1	mA
ЧН	V _{CC} = MAX,	V ₁ = 2.4 V				40			40	μА
IL	V _{CC} = MAX,	V _I = 0.4 V				– 1.6			- 1.6	mA
IOS§	V _{CC} = MAX			- 20		– 70	- 18		– 70	mA
ГССН	V _{CC} = MAX,	V ₁ = 0			4	8		4	8	mA
ICCL	V _{CC} = MAX,	V ₁ = 4.5 V			17	27		17	27	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	TEST CONDITIONS				UNIT
tPLH .	A 21/		D. = 122 O	C. = 15 o 5		13	22	กร
tPHL	Any	· ·	$R_L = 133 \Omega$,	C _L = 15 pF		8	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$. § Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed 100 milliseconds.

SDLS108 - APRIL 1985 - REVISED MARCH 1988

recommended operating conditions

	\$	SN54LS40			N74LS	UNIT	
	MIN	NOM	MAX	MIN	NOM	MAX	ONT
V _{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH High-level input voltage	2			2			٧
VIL Low-level input voltage			0.7			0 8	
IOH High-level output current			- 1.2			– 1.2	mA
IOL Low-level output current			12			24	mA
TA Operating free-air temperature	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEGT CONDITIONS \$		S	N54LS4	10	S	10	UNIT	
PARAMETER		TEST CONDITIONS T			TYP ‡	MAX	MIN	TYP‡	MAX	ONT
VIK	V _{CC} = MIN,	I _I = - 18 mA				- 1.5			– 1.5	V
V _{OH}	V _{CC} = MIN,	VIL = MAX,	I _{OH} = - 1.2 mA	2.5	3.4		2.7	3.4		٧
V	V _{CC} = MIN,	V _{IH} = 2 V,	I _{OL} = 12 mA		0.25	0.4		0.25	0.4	V
VOL	V _{CC} = MIN,	V _{IH} = 2 V,	IOL = 24 mA					0.35	0.5	
l ₁	V _{CC} = MAX,	V ₁ = 7 V				0.1			0.1	mA
ЧН	V _{CC} = MAX,	V _I = 2.7 V				20			20	μΑ
ΙΙL	V _{CC} = MAX,	V _I = 0.4 V				- 0.4			- 0.4	mA
IOS §	V _{CC} = MAX			- 30		– 130	– 30		– 130	mA
ГССН	V _{CC} = MAX,	V ₁ = 0			0.45	1		0.45	11	mA
ICCL	V _{CC} = MAX,	V ₁ = 4.5 V			3	6		3	6	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

1 1 (1	NPUT)	(OUTPUT)	TEST CON	DITIONS	MIN	TYP	MAX	UNIT
tPLH A	Any	Y	R _L = 667 Ω,	C _L = 45 pF		12	24 24	ns ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25 ^{\circ} \text{C}$. § Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

SDLS108 – APRIL 1985 – REVISED MARCH 1988

recommended operating conditions

		SN54S4	0	SN74S40		UNIT	
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V _{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
VIH High-level input voltage	2			2			٧
VIL Low-level input voltage			0.8			0.8	V
IOH High-level output current			- 3			- 3	mA
IOL Low-level output current			60			60	mA
T _A Operating free-air temperature	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

242445752		TEST CONDITIONS †			SN54S40)		SN74S40	0	UNIT
PARAMETER		TEST CONDITIONS I				MAX	MIN	TYP‡	MAX	ONIT
VIK	V _{CC} = MIN,	I _I = - 18 mA				- 1.2			- 1.2	>
Voн	V _{CC} = MIN,	V _{1L} = 0.8 V,	I _{OH} = - 3 mA	2.5	3.4		2.7	3.4		V
VOL	V _{CC} = MIN,	V _{IH} = 2 V,	I _{OL} = 60 mA			0.5			0.5	٧
11	V _{CC} = MAX,	V _I = 5.5 V				1			1	mA
ЧН	V _{CC} = MAX,	V _I = 2.7 V				0.1			0.1	mA
¹ 1L	V _{CC} = MAX,	V _I = 0.5 V				- 4			- 4	mA
los\$	V _{CC} = MAX			- 50		- 225	- 50		- 225	mA
1ссн	V _{CC} = MAX,	V ₁ = 0			10	18		10	18	mA
ICCL	V _{CC} = MAX,	V ₁ = 4.5 V			25	44		25	44	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST COM	MIN TYP	MAX	UNIT	
t _{PLH}			P. = 02 O	C _L = 50 pF	4	6.5	ns
^t PHL	A 214		R _L = 93 Ω,	OE - 20 bi	4	6.5	ns
^t PLH	Any	l ' [R _L = 93 Ω,	C _I = 150 pF	6		ns
^t PHL			HE = 50 46,	CL 130 pr	6		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[§] Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed 100 milliseconds.

IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1999, Texas Instruments Incorporated